SDAS010B - MARCH 1984 - REVISED DECEMBER 1994

 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

#### description

These devices contain an 8-input positive-NAND gate and perform the following Boolean functions in positive logic:

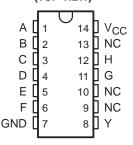
$$Y = \overline{A \cdot B \cdot C \cdot D \cdot E \cdot F \cdot G \cdot H}$$
  
 $Y = \overline{A + B + C + D + E + F + G + H}$ 

The SN54ALS30A and SN54AS30 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS30A and SN74AS30 are characterized for operation from 0°C to 70°C.

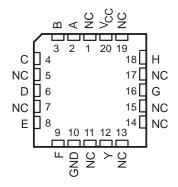
**FUNCTION TABLE** 

INPUTS A-H	OUTPUT Y
All inputs H	L
One or more inputs L	Н

#### SN54ALS30A, SN54AS30 . . . J PACKAGE SN74ALS30A, SN74AS30 . . . D OR N PACKAGE (TOP VIEW)

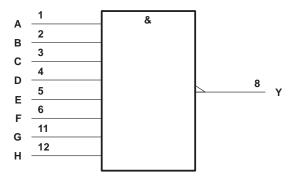


# SN54ALS30A, SN54AS30 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

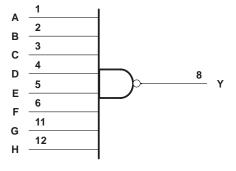
#### logic symbol†



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

#### logic diagram (positive logic)



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN54ALS30A	-55°C to 125°C
SN74ALS30A	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions

		SN54ALS30A			SN	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
\/ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	and lavel in a structure			0.8‡		0.8		V
VIL	Low-level input voltage			0.7§				V
ІОН	High-level output current			-0.4			-0.4	mA
loL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

<sup>‡</sup> Applies over temperature range -55°C to 70°C

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEOT 0	TEST CONDITIONS		SN54ALS30A			SN74ALS30A			
PARAMETER	lesi C			TYP¶	MAX	MIN	TYP¶	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.5			-1.5	V	
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> –	2		VCC -2	2		V	
Voi	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 4 mA		0.25	0.4		0.25	0.4	V	
VOL	VCC = 4.5 V	I <sub>OL</sub> = 8 mA					0.35	0.5	V	
lį	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 7 V			0.1			0.1	mA	
lіН	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			20			20	μΑ	
I <sub>IL</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.1			-0.1	mA	
10 <sup>#</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA	
Iссн	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 0		0.22	0.36		0.22	0.36	mA	
ICCL	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 4.5 V		0.54	0.9		0.54	0.9	mA	

 $<sup>\</sup>P$  All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>§</sup> Applies over temperature range 70°C to 125°C

<sup>#</sup>The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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#### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C <sub>L</sub> R <sub>L</sub>	$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, $R_L$ = 500 $\Omega$ , $T_A$ = MIN to MAX <sup>†</sup>		UNIT	
	, ,	, ,	SN54ALS30A		SN74ALS30A		
			MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	A, B, C, D, E, F, G, or H	V	3	15	3	10	ns
t <sub>PHL</sub>	A, B, C, D, E, F, G, OI II	Y	3	15	3	12	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN54AS30	-55°C to 125°C
SN74AS30	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN54AS30			S	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage			8.0			0.8	V
ІОН	High-level output current			-2			-2	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST C	ST CONDITIONS		SN54AS30			SN74AS30			
PARAMETER	IESI C			N TYP§	MAX	MIN	TYP§	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	I <sub>I</sub> = -18 mA			-1.2			-1.2	V	
VOH	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	Vсс	-2		V <sub>CC</sub> -2	2		V	
VOL	$V_{CC} = 4.5 V,$	$I_{OL} = 20 \text{ mA}$		0.35	0.5		0.35	0.5	V	
lį	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 7 V			0.1			0.1	mA	
lН	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 2.7 V			20			20	μΑ	
I <sub>Ι</sub> L	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 0.4 V			-0.5			-0.5	mA	
ΙΟ <sup>¶</sup>	$V_{CC} = 5.5 V,$	V <sub>O</sub> = 2.25 V	-3	)	-112	-30		-112	mA	
IССН	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 0		0.9	1.5		0.9	1.5	mA	
ICCL	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 4.5 V		3	4.9		3	4.9	mA	

<sup>§</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, Ios.



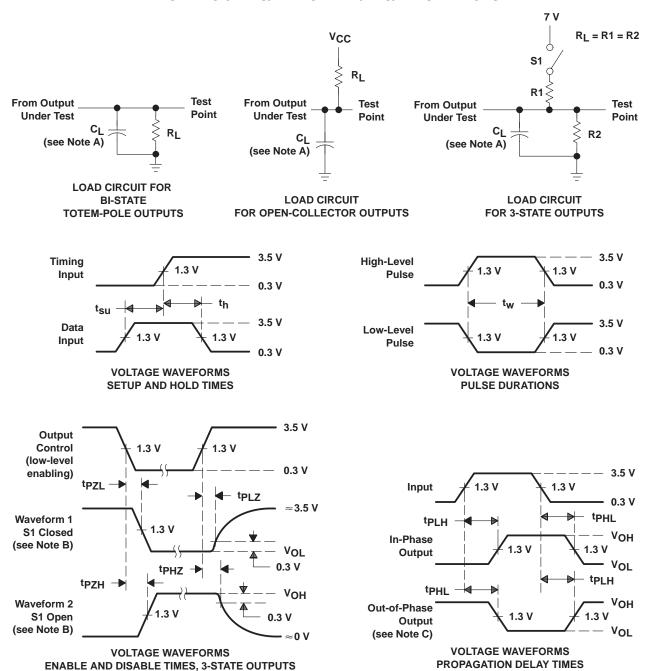
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## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C <sub>L</sub> R <sub>L</sub> T <sub>A</sub>	$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, $R_L$ = 500 Ω, $T_A$ = MIN to MAX <sup>†</sup> SN54AS30 SN74AS30		<b>F</b> , Ω,		
			MIN	MAX	MIN	MAX		
t <sub>PLH</sub>	A, B, C, D, E, F, G, or H	V	1	5.5	1	5	ns	
t <sub>PHL</sub>	A, D, C, D, E, F, G, 0111	1	1	5	1	4.5	115	

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics:  $PRR \le 1$  MHz,  $t_f = t_f = 2$  ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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